

TEST REPORT

FCC WPT Test for SM-F766B
Certification

APPLICANT
SAMSUNG Electronics Co., Ltd.

REPORT NO.
HCT-SR-2505-FC006

DATE OF ISSUE
May 12, 2025

Tested by
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TEST REPORT

FCC WPC RF
Exposure Test for
certification

REPORT NO.
HCT-SR-2505-FC006

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May. 12, 2025

FCC ID
A3LSMF766B

Applicant **SAMSUNG Electronics Co., Ltd**
129, Samsung-ro, Yeongtong-gu, Suwon-Si, Gyeonggi-do, 16677, Korea

Product Name **Mobile Phone**
Model Name **SM-F766B**

Date of Test **Apr. 25, 2025**

Location of Test ☒ Permanent Testing Lab ☐ On Site Testing Lab
(Address: 74, Seoicheon-ro 578beon-gil, Majang-myeon, Icheon-si,

FCC Rule Part(s) **FCC Part 1 SUBPART I**
FCC Part 2 SUBPART J
KDB 680106 D01

Test Results **PASS**

REVISION HISTORY

The revision history for this test report is shown in table.

Revision No.	Date of Issue	Description
0	May. 12, 2025	Initial Release

Notice

Content

The results shown in this test report only apply to the sample(s), as received, provided by the applicant, unless otherwise stated.

The test results have only been applied with the test methods required by the standard(s).

The laboratory is not accredited for the test results marked *.

Information provided by the applicant is marked **.

Test results provided by external providers are marked ***.

When confirmation of authenticity of this test report is required, please contact www.hct.co.kr

The test results in this test report are not associated with the ((KS Q) ISO/IEC 17025) accreditation by KOLAS (Korea Laboratory Accreditation Scheme) / A2LA (American Association for Laboratory Accreditation) that are under the ILAC (International Laboratory Accreditation Cooperation) Mutual Recognition Agreement (MRA).

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1. Test Methodology

The DUT was assessed in accordance with 680106 D01 Wireless Power Transfer v04.

2. Test Location

2.1 Test Laboratory

Company Name	HCT Co., Ltd.
Address	74, Seoicheon-ro 578beon-gil, Majang-myeon, Icheon-si, Gyeonggi-do, 17383 KOREA
Telephone	031-645-6300
Fax.	031-645-6401

2.2 Test Facilities

Our laboratories are accredited and approved by the following approval agencies according to ISO/IEC 17025.

Korea	National Radio Research Agency (Designation No. KR0032)
	KOLAS (Testing No. KT197)

3. DEVICE UNDER TEST DESCRIPTION

Applicant Name:	SAMSUNG Electronics Co., Ltd.
Model Name	SM-F766B
EUT Type:	Mobile Phone
Application Type:	Certification

3.1 Description of DUT

The DUT is a mobile phone with a WPT (Wireless Power Transfer) feature using an inductive charging coil to charge a phone and a watch. The charging frequency is between 110 kHz to 148 kHz, and the maximum transfer power consumption is 9 W in charging status.

3.2 Test Configurations

Test configurations	Description
DUT to Phone test configuration 1	Charging from Phone to DUT
DUT to Phone test configuration 2	Charging from Phone to DUT (TA Charging from DUT)
DUT to Phone test configuration 3	Charging from Phone to DUT
DUT to Phone test configuration 4	Charging from Phone to DUT (TA Charging from DUT)
DUT to Phone test configuration 5	Charging from Watch to DUT
DUT to Phone test configuration 6	Charging from Watch to DUT (TA Charging from DUT)
DUT to Phone test configuration 7	Charging from Ear buds to DUT
DUT to Phone test configuration 8	Charging from Ear buds to DUT (TA Charging from DUT)

Note:

1. Configuration 2,4 6 and 8 were tested with the worst case of configuration 1,3,5 and 7
2. The DUT was tested in the worst case configuration, considering both open and close charging conditions.

3.3 KDB 680106 D01 Wireless Power Transfer v04. SECTION 5.2)

Requirement	Device
(1) Power transfer frequency is less than 1 MHz.	Yes. Operation Frequency is between 110 kHz to 148 kHz.
(2) Output power from each primary coil is less than or equal to 15 watts.	Yes. Maximum power is 9 Watts.
(3) A client device providing the maximum permitted load is placed in physical contact with the transmitter (i.e., the surfaces of the transmitter and client device enclosures need to be in physical contact)	Yes.
(4) Only § 2.1091-Mobile exposure conditions apply	Yes.
(5) The E-field and H-field strengths, at and beyond 20 cm surrounding the device surface, are demonstrated to be less than 50% of the applicable MPE limit, per KDB 447498, Table 1.	Yes. The field strengths at 20 cm from the device is 3.620 % for the H field and 0.065 % for the E-Field Limit
(6) For systems with more than one radiating structure, the conditions specified in (5) must be met when the system is fully loaded (i.e., clients absorbing maximum power available), and with all the radiating structures operating at maximum power at the same time, as per design conditions. If the design allows one or more radiating structures to be powered at a higher level while other radiating structures are not powered, then those cases must be tested as well. For instance, a device may use three RF coils powered at 5 W, or one coil powered at 15 W: in this case, both scenarios shall be tested	No, it is a single radiating structure.

3.4 DESCRIPTION OF TEST SETUP

SUPPORT EQUIPMENT & PERIPHERALS

SUPPORT EQUIPMENT & PERIPHERALS LIST				
Description	Manufacturer	Model	Serial Number	FCC ID
Watch	SAMSUNG Electronics Co., Ltd.	SM-R840N	RFANC0N5S2A	A3LSMR840
Ear Buds	SAMSUNG Electronics Co., Ltd.	SM-R530	RFAX82HVFEH	A3LSMR530L A3LSMR530R
Phone	SAMSUNG Electronics Co., Ltd.	SM-F766B	YDF1395M	-

TEST SETUP

The following three modes are tested in test configuration;

All Position of client device were investigated and the worst position results are reported.

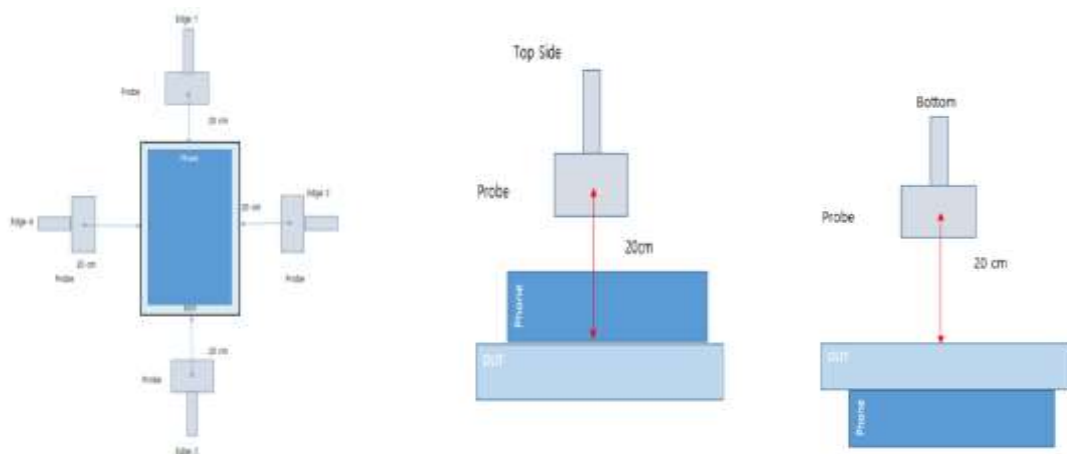
Mode
Operating (SUPPORT Equipment, <10% Power Charging)
Operating (SUPPORT Equipment, 50~55% Power Charging)
Operating (SUPPORT Equipment, 90~95% Power Charging)

MEASUREMENT TEST SETUP

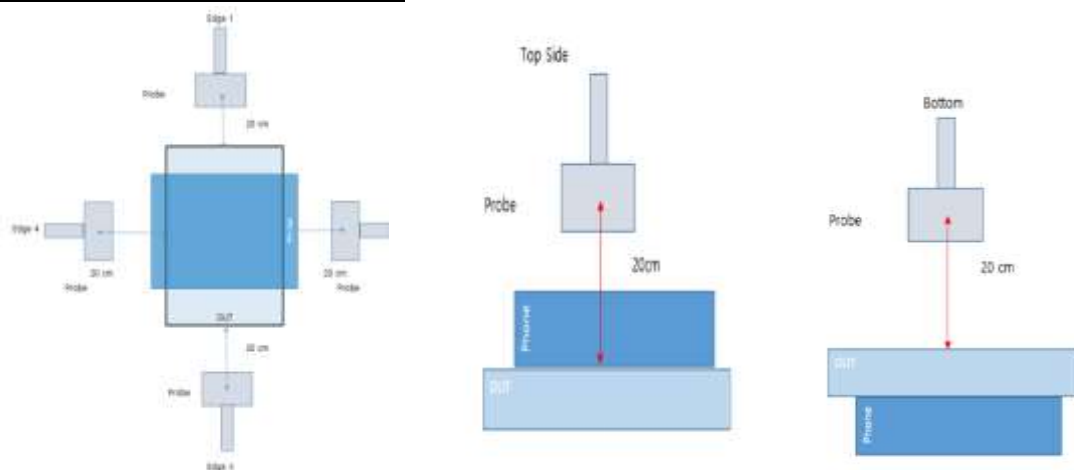
The measurement was taken using a probe place 20 cm from the all edges of DUT above the DUT. Measurement were from the top and all sides of the DUT per 680106 D01 Wireless Power Transfer v04. Additionally, as the DUT to phone configuration could result with the DUT place either above or below the phone, measurements were performed 'below' the DUT by flipping the DUT/phone so that the DUT was uppermost.

The probe was moved along the edges or above the DUT to a position that showed the maximum field strength. This position was used for the reported result.

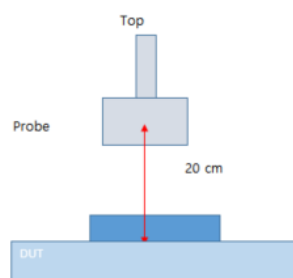
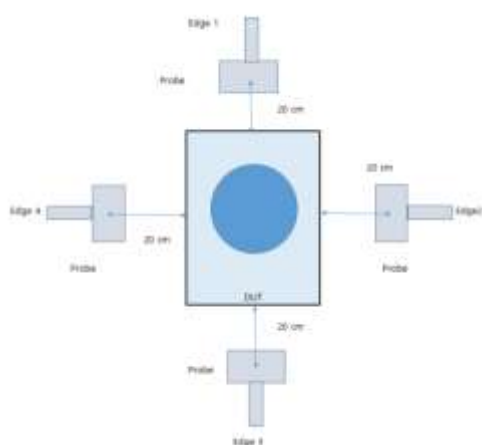
DUT to phone test Configuration 1 & 2



DUT to phone test Configuration 3 & 4



DUT to Watch/Ear buds test Configuration 5 & 6 and 7 & 8



4. TEST AND MEASUREMENT EQUIPMENT

The following test and measurement equipment was used for the tests documented in this report:

Manufacturer	Model name	Description	S/N	Calib. Date	Calib.Due
Narda	EHP 200AC	Electric and Magnetic Field Probe	170WX91009	02/13/2024	02/13/2026

5. MAXIMUM PERMISSIBLE RF EXPOSURE

1.13010 The criteria listed in Table 1 shall be used to evaluate the environmental impact of human exposure to radio-frequency(RF) radiation as specified in 1.1307(b), except in the case of portable devices which shall be evaluated according the provisions of 2.1093 of this chapter.

TABLE 1—LIMITS FOR MAXIMUM PERMISSIBLE EXPOSURE (MPE)

Frequency range (MHz)	Electric field strength (V/m)	Magnetic field strength (A/m)	Power density (mW/cm ²)	Averaging time (minutes)
(A) Limits for Occupational/Controlled Exposures				
0.3–3.0	614	1.63	*(100)	6
3.0–30	1842/f	4.89/f	*(900/f ²)	6
30–300	61.4	0.163	1.0	6
300–1500			f/300	6
1500–100,000			5	6
(B) Limits for General Population/Uncontrolled Exposure				
0.3–1.34	614	1.63	*(100)	30
1.34–30	824/f	2.19/f	*(180/f ²)	30

TABLE 1—LIMITS FOR MAXIMUM PERMISSIBLE EXPOSURE (MPE)—Continued

Frequency range (MHz)	Electric field strength (V/m)	Magnetic field strength (A/m)	Power density (mW/cm ²)	Averaging time (minutes)
30–300	27.5	0.073	0.2	30
300–1500			f/1500	30
1500–100,000			1.0	30

f = frequency in MHz

* = Plane-wave equivalent power density

NOTE 1 TO TABLE 1: Occupational/controlled limits apply in situations in which persons are exposed as a consequence of their employment provided those persons are fully aware of the potential for exposure and can exercise control over their exposure. Limits for occupational/controlled exposure also apply in situations when an individual is transient through a location where occupational/controlled limits apply provided he or she is made aware of the potential for exposure.

NOTE 2 TO TABLE 1: General population/uncontrolled exposures apply in situations in which the general public may be exposed, or in which persons that are exposed as a consequence of their employment may not be fully aware of the potential for exposure or can not exercise control over their exposure.

6. TEST RESULTS

H-Field Measurements

Note : peak measurements were performed. RMS values were calculated from the peak measurement.

Please refer to the formula for calculating the RMS value: [Field Strength * $\sqrt{\text{Duty Cycle}}$]

TEST results of DUT to phone test Configuration 1&2

FCC RF Exposure Result					
Test Configuration	Test mode	Test distance	Test Position	H-Field Limit (A/m)	H-Field meas data (A/m)
Configuration 1	Operation Real Product (Power <10% charging)	20 cm	Top	1.63	0.058
			Bottom		0.052
			Edge 1		0.053
			Edge 2		0.056
			Edge 3		0.055
			Edge 4		0.057
	Operation Real Product (Power 50~55% charging)	20 cm	Top	1.63	0.054
			Bottom		0.054
			Edge 1		0.054
			Edge 2		0.053
			Edge 3		0.054
			Edge 4		0.054
	Operation Real Product (Power 90~95% charging)	20 cm	Top	1.63	0.054
			Bottom		0.056
			Edge 1		0.052
			Edge 2		0.054
			Edge 3		0.056
			Edge 4		0.052
Configuration 2	Operation Real Product (Power <10% charging)	20 cm	Top	1.63	0.059

TEST results of DUT to phone test Configuration 3&4

FCC RF Exposure Result					
Test Configuration	Test mode	Test distance	Test Position	H-Field Limit (A/m)	H-Field meas data (A/m)
Configuration 3	Operation Real Product (Power <10% charging)	20 cm	Top	1.63	0.058
			Bottom		0.057
			Edge 1		0.054
			Edge 2		0.054
			Edge 3		0.052
			Edge 4		0.054
	Operation Real Product (Power 50~55% charging)	20 cm	Top	1.63	0.055
			Bottom		0.055
			Edge 1		0.052
			Edge 2		0.052
			Edge 3		0.056
			Edge 4		0.056
	Operation Real Product (Power 90~95% charging)	20 cm	Top	1.63	0.055
			Bottom		0.054
			Edge 1		0.054
			Edge 2		0.051
			Edge 3		0.053
			Edge 4		0.052
Configuration 4	Operation Real Product (Power <10% charging)	20 cm	Top	1.63	0.059

TEST results of DUT to Watch test Configuration 5&6

FCC RF Exposure Result					
Test Configuration	Test mode	Test distance	Test Position	H-Field Limit (A/m)	H-Field meas data (A/m)
Configuration 5	Operation Real Product (Power <10% charging)	20 cm	Top	1.63	0.058
			Edge 1		0.054
			Edge 2		0.056
			Edge 3		0.055
			Edge 4		0.054
	Operation Real Product (Power 50~55% charging)	20 cm	Top	1.63	0.053
			Edge 1		0.053
			Edge 2		0.054
			Edge 3		0.054
			Edge 4		0.055
	Operation Real Product (Power 90~95% charging)	20 cm	Top	1.63	0.054
			Edge 1		0.055
			Edge 2		0.054
			Edge 3		0.056
			Edge 4		0.054
Configuration 6	Operation Real Product (Power <10% charging)	20 cm	Top	1.63	0.057

TEST results of DUT to Ear Buds test Configuration 7&8

FCC RF Exposure Result					
Test Configuration	Test mode	Test distance	Test Position	H-Field Limit (A/m)	H-Field meas data (A/m)
Configuration 7	Operation Real Product (Power <10% charging)	20 cm	Top	1.63	0.072
			Edge 1		0.055
			Edge 2		0.020
			Edge 3		0.056
			Edge 4		0.054
	Operation Real Product (Power 50~55% charging)	20 cm	Top	1.63	0.074
			Edge 1		0.057
			Edge 2		0.051
			Edge 3		0.057
			Edge 4		0.059
	Operation Real Product (Power 90~95% charging)	20 cm	Top	1.63	0.066
			Edge 1		0.057
			Edge 2		0.055
			Edge 3		0.063
			Edge 4		0.054
Configuration 8	Operation Real Product (Power 50~55% charging)	20 cm	Top	1.63	0.076

E-Field Measurements

Note: peak measurements were performed. RMS values were calculated from the peak measurement.

Please refer to the formula for calculating the RMS value: [Field Strength * $\sqrt{\text{Duty Cycle}}$]

TEST results of DUT to phone test Configuration 1&2

FCC RF Exposure Result					
Test Configuration	Test mode	Test distance	Test Position	E-Field Limit (V/m)	E-Field meas data (V/m)
Configuration 1	Operation Real Product (Power <10% charging)	20 cm	Top	614	0.335
			Bottom		0.368
			Edge 1		0.334
			Edge 2		0.346
			Edge 3		0.343
			Edge 4		0.377
	Operation Real Product (Power 50~55% charging)	20 cm	Top	614	0.341
			Bottom		0.379
			Edge 1		0.357
			Edge 2		0.384
			Edge 3		0.325
			Edge 4		0.326
	Operation Real Product (Power 90~95% charging)	20 cm	Top	614	0.385
			Bottom		0.376
			Edge 1		0.364
			Edge 2		0.334
			Edge 3		0.368
			Edge 4		0.343
Configuration 2	Operation Real Product (Power 90~95% charging)	20 cm	Top	614	0.398

TEST results of DUT to phone test Configuration 3&4

FCC RF Exposure Result					
Test Configuration	Test mode	Test distance	Test Position	E-Field Limit (V/m)	E-Field meas data (V/m)
Configuration 3	Operation Real Product (Power <10% charging)	20 cm	Top	614	0.343
			Bottom		0.365
			Edge 1		0.346
			Edge 2		0.345
			Edge 3		0.338
			Edge 4		0.334
	Operation Real Product (Power 50~55% charging)	20 cm	Top	614	0.338
			Bottom		0.372
			Edge 1		0.347
			Edge 2		0.358
			Edge 3		0.334
			Edge 4		0.326
	Operation Real Product (Power 90~95% charging)	20 cm	Top	614	0.378
			Bottom		0.355
			Edge 1		0.335
			Edge 2		0.373
			Edge 3		0.326
			Edge 4		0.365
Configuration 4	Operation Real Product (Power 90~95% charging)	20 cm	Top	614	0.378

TEST results of DUT to Watch test Configuration 5&6

FCC RF Exposure Result					
Test Configuration	Test mode	Test distance	Test Position	E-Field Limit (V/m)	E-Field meas data (V/m)
Configuration 5	Operation Real Product (Power <10% charging)	20 cm	Top	614	0.362
			Edge 1		0.358
			Edge 2		0.354
			Edge 3		0.357
			Edge 4		0.346
	Operation Real Product (Power 50~55% charging)	20 cm	Top	614	0.358
			Edge 1		0.335
			Edge 2		0.349
			Edge 3		0.308
			Edge 4		0.355
	Operation Real Product (Power 90~95% charging)	20 cm	Top	614	0.335
			Edge 1		0.283
			Edge 2		0.357
			Edge 3		0.334
			Edge 4		0.307
Configuration 6	Operation Real Product (Power <10% charging)	20 cm	Top	614	0.362

TEST results of DUT to Ear Buds test Configuration 7&8

FCC RF Exposure Result					
Test Configuration	Test mode	Test distance	Test Position	E-Field Limit (V/m)	E-Field meas data (V/m)
Configuration 7	Operation Real Product (Power <10% charging)	20 cm	Top	614	0.343
			Edge 1		0.358
			Edge 2		0.279
			Edge 3		0.349
			Edge 4		0.290
	Operation Real Product (Power 50~55% charging)	20 cm	Top	614	0.402
			Edge 1		0.338
			Edge 2		0.338
			Edge 3		0.357
			Edge 4		0.334
	Operation Real Product (Power 90~95% charging)	20 cm	Top	614	0.390
			Edge 1		0.283
			Edge 2		0.346
			Edge 3		0.343
			Edge 4		0.346
Configuration 8	Operation Real Product (Power 50~55% charging)	20 cm	Top	614	0.397

7. Conclusion

	H-Field (A/m)	E-Field (V/m)
MPE Limit	1.63	614
Maximum Measurement Result	0.059	0.398
Percentage (%)	3.620	0.065

H-Field, E-Field test result was less than 50% of MPE Limit